# MT82P01N3

# P-Channel Enhancement Mode Field Effect Transistor

# **Product Summary**

- V<sub>DS</sub>= -20V
- ID= -3.5A
- RDS(ON)  $75m\Omega$  @VGS= -4.5V/-3.5A

## **Features**

- · Advanced Trench Process Technology.
- High Density Cell Design for Ultra Low
- · On-Resistance.
- · Lead free product is acquired.
- RoHS Compliant.

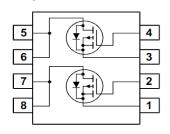
# **Applications:**

- · Load Switch.
- · PWM Applications.

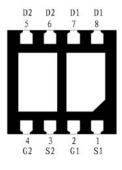


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## Simplified Schematic



#### MARKING DIAGRAM & PIN ASSIGNMENT



# **Absolute Maximum Ratings** (T<sub>A</sub> = 25℃ unless otherwise noted)

Symbol	Parameter	Steady State	Units
V <sub>DS</sub>	Drain-Source Voltage	-20	V
V <sub>GS</sub>	Gate-Source Voltage	±12	v
I <sub>D</sub>	Continuous Drain Current <sup>1</sup>	-3.5	A
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	-18	A
Is	Continuous Source Current (Diode Conduction) 1	-2	Α
P <sub>D</sub>	Maximum Power Dissipation <sup>1</sup>	1.1	W
T <sub>J</sub> , T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55~150	$^{\circ}$

#### Notes:

- 1. Surface Mounted on 1" x 1" FR4 Board, t≦ 10 Sec.
- 2. Pulse width limited by maximum junction temperature.

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT82P01N3	MT82P01N3	DFN3*3	-	-	3000

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## **Thermal Characteristic**

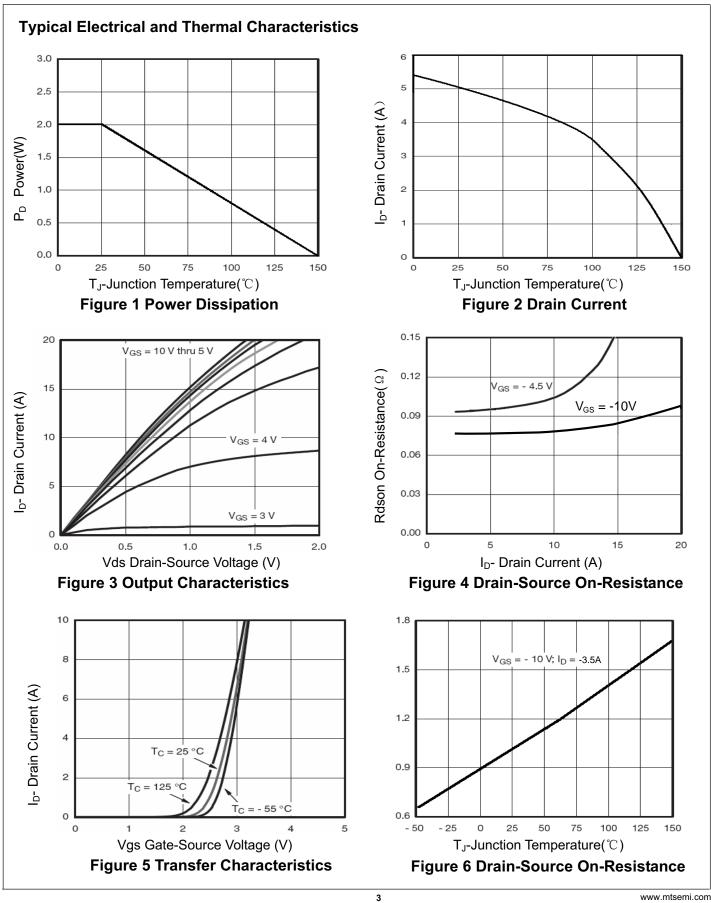
Thermal Resistance ,Junction-to-Ambient <sup>(Note 2)</sup>	R <sub>0JA</sub>	125.5	°C /W	
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# Electrical Characteristics (T<sub>A</sub>=25 ℃ unless otherwise noted)

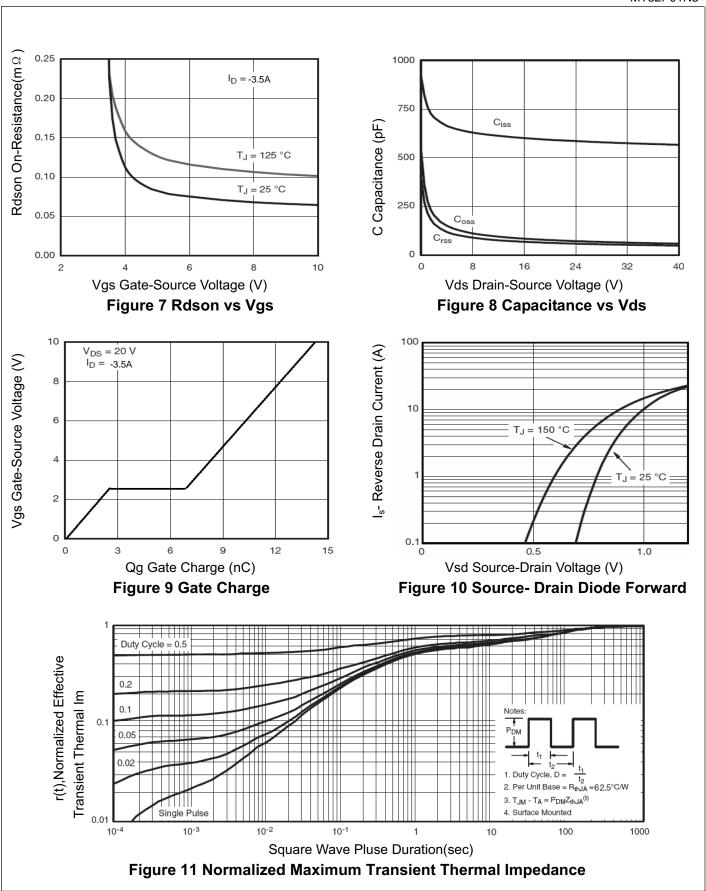
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						•
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-20	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-20V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±12V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)						•
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=-250\mu A$	-	-0.7	-1.0	V
Davis Occurs On Otata Basistanas		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3.5A	-	75	80	mΩ
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-3.5A	-	120	130	mΩ
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =-15V,I <sub>D</sub> =-3.1A	10	-	-	S
Dynamic Characteristics (Note4)			'	1	'	
Input Capacitance	C <sub>lss</sub>	V <sub>DS</sub> =-20V,V <sub>GS</sub> =0V, F=1.0MHz	-	570	-	PF
Output Capacitance	Coss		-	85	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F-1.UIVITZ	-	65	-	PF
Switching Characteristics (Note 4)	·		•			
Turn-on Delay Time	t <sub>d(on)</sub>		-	9	-	nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =-20 $V$ , $R_L$ =2 $\Omega$	-	8	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =-10V, $R_{GEN}$ =3 $\Omega$	-	28	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	10	-	nS
Total Gate Charge	Qg	V <sub>DS</sub> =-20V,I <sub>D</sub> =-4.5A,	-	12	-	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ 20V, $I_{D}$ 4.5A, $V_{GS}$ =-10V	-	2.9	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	v <sub>GS</sub> 10 v	-	3.8	-	nC
Drain-Source Diode Characteristics	,			•	•	
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-1A	-	-0.8	-1.2	V
Diode Forward Current (Note 2)	Is		-	-	-3.5	А

#### Notes:

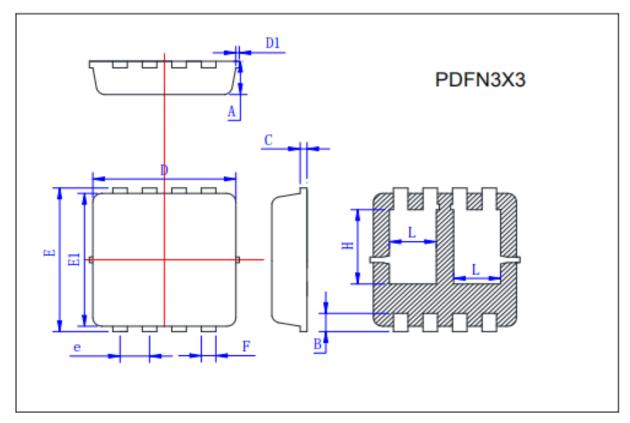
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
  4. Guaranteed by design, not subject to production



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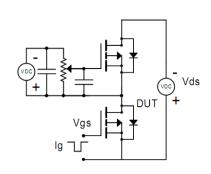


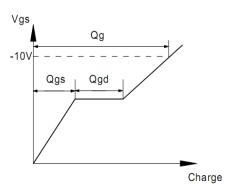
# **PACKAGE OUTLINE DIMENSIONS**



Symbol	Min	Тур	Max
A	0.725	0.775	0.825
В	0.28	0.38	0.48
C	0.13	0.15	0.20
D	3.05	3.15	3.25
D1			0.10
E	3.25	3.35	3.45
E1	3.0	3.1	3.2
e	0.60	0.65	0.70
F	0.27	0.32	0.37
Н	1.63	1.73	1.83
L	0.93	1.03	1.13

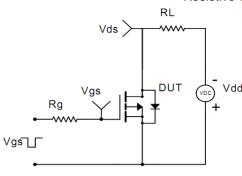
#### Gate Charge Test Circuit & Waveform

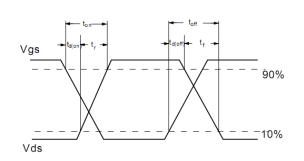




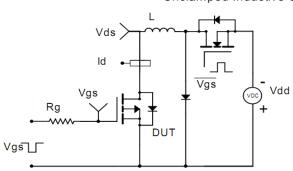
Resistive Switching Test Circuit & Waveforms

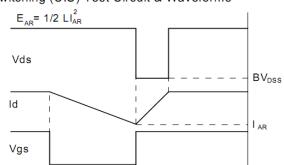
#### Resistive Switching Test Circuit & Waveforms



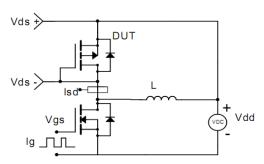


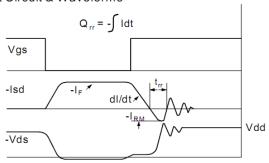
# Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms





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